Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/586,601	ONO, SHUJI
Examiner	Art Unit

Nhan T. Tran

2622

	SEAR	CHED	
Class	Subclass	Date	Examiner

INT	TERFERENC	ERENCE SEARCHED		
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Used previously cited references	5/8/2006	NT	